Identification and tunable optical coherent control of transition-metal spins in silicon carbide

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Color centers in wide-bandgap semiconductors are attractive systems for quantum technologies since they can combine long-coherent electronic spin and bright optical properties. Several suitable centers have been identified, most famously the nitrogen-vacancy defect in diamond. However, integration in communication technology is hindered by the fact that their optical transitions lie outside telecom wavelength bands. Several transition-metal impurities in silicon carbide do emit at and near telecom wavelengths, but knowledge about their spin and optical properties is incomplete. We present all-optical identification and coherent control of molybdenum-impurity spins in silicon carbide with transitions at near-infrared wavelengths. Our results identify spin $S = \frac{1}{2}$ for both the electronic ground and excited state, with highly anisotropic spin properties that we apply for implementing optical control of ground-state spin coherence. Our results show optical lifetimes of $\sim 60$ ns and inhomogeneous spin dephasing times of $\sim 0.3$ $\mu$s, establishing relevance for quantum spin-photon interfacing.

INTRODUCTION

Electronic spins of lattice defects in wide-bandgap semiconductors have come forward as an important platform for quantum technologies, in particular for applications that require both manipulation of long-coherent spin and spin-photon interfacing via bright optical transitions. In recent years this field showed strong development, with demonstrations of distribution and storage of non-local entanglement in networks for quantum communication2-6 and quantum-enhanced field-sensing.7 The nitrogen-vacancy defect in diamond is the material system that is most widely studied12,13 and best characterized14-16 for these applications. However, its zero-phonon-line (ZPL) transition wavelength (637 nm) is not optimal for integration in standard telecom technology, which uses near-infrared wavelength bands where losses in optical fibers are minimal. A workaround could be to convert photon energies between the emitter-resonance and telecom wavelengths,17-19 but optimizing these processes is very challenging.

This situation has been driving a search for similar lattice defects that do combine favorable spin properties with bright emission directly at telecom wavelength. It was shown that both diamond and silicon carbide (SiC) can host many other spin-active color centers that could have suitable properties.20-23 (where SiC is also an attractive material for its established position in the semiconductor device industry.24,25) However, for many of these color centers detailed knowledge about the spin and optical properties is lacking. In SiC the divacancy26-28 and silicon vacancy10,29-31 were recently explored, and these indeed show millisecond homogeneous spin coherence times with bright ZPL transitions closer to the telecom band.

We present here a study of transition-metal impurity defects in SiC, which exist in great variety.32-37 There is at least one case (the vanadium impurity) that has ZPL transitions at telecom wavelengths33 around 1300 nm, but we focus here (directed by availability of lasers in our lab) on the molybdenum impurity with ZPL transitions at 1076 nm (in 4H-SiC) and 1121 nm (in 6H-SiC), which turns out to be a highly analogous system. Theoretical investigations,38 early electron paramagnetic resonance (EPR), and photoluminescence (PL) studies39-42 indicate that these transition-metal impurities have promising properties. These studies show that they are deep-level defects that can be in several stable charge states, each with a distinctive value for its electronic spin $S$ and near-infrared optical transitions. Further tuning and engineering possibilities come from the fact that these impurities can be embedded in a variety of SiC polytypes (4H, 6H, etc., Fig. 1a). Recent work by Koehl et al.37 studied chromium impurities in 4H-SiC using optically detected magnetic resonance. They identified efficient ZPL (little phonon-sideband) emission at 1042 nm and 1070 nm, and their charge state as neutral with an electronic spin $S = 1$ for the ground state.

Our work is an all-optical study of ensembles of molybdenum impurities in p-type 4H-SiC and 6H-SiC material. The charge and spin configuration of these impurities, and the defect configuration in the SiC lattice that is energetically favored, was until our work not yet identified with certainty. Our results show that these Mo impurities are in the Mo$^{5+}$ (4d$^1$) charge state (we follow here conventional notation);33 the label S+ indicates that of an original...
In what follows, we first present our methods and results of single-laser spectroscopy performed on ensembles of Mo impurities in both SiC polytypes. Next, we discuss a two-laser method where optical spin pumping is detected. This allows for characterizing the spin sublevels in the ground and excited state, and we demonstrate how this can be extended to controlling spin coherence.

Both the 6H-SiC and 4H-SiC (Fig. 1a) samples were intentionally doped with Mo. There was no further intentional doping, but near-band-gap photoluminescence revealed that both materials had p-type characteristics. The Mo concentrations in the 4H and 6H samples were estimated to be in the range $10^{15} - 10^{17}$ cm$^{-3}$ and $10^{14} - 10^{16}$ cm$^{-3}$, respectively. The samples were cooled in a liquid-helium flow cryostat with optical access, which was equipped with a superconducting magnet system. The set-up geometry is depicted in Fig. 1b. The angle $\phi$ between the direction of the magnetic field and the c-axis of the crystal could be varied, while both of these directions were kept orthogonal to the propagation direction of excitation laser beams. In all experiments where we resonantly addressed ZPL transitions the laser fields had linear polarization, and we always kept the direction of the linear polarization parallel to the c-axis. Earlier studies of these materials showed that the ZPL transition dipoles are parallel to the c-axis. For our experiments we confirmed that the photoluminescence response was clearly the strongest for excitation with linear polarization parallel to the c-axis, for all directions and magnitudes of the magnetic fields that we applied. All results presented in this work come from photoluminescence (PL) or photoluminescence excitation (PLE) measurements. The excitation lasers were focused to a $\sim 100$ μm spot in the sample. PL emission was measured from the side. A more complete description of experimental aspects is presented in Methods section.

RESULTS

For initial characterization of Mo transitions in 6H-SiC and 4H-SiC we used PL and PLE spectroscopy (Methods). Figure 1c shows the PL emission spectrum of the 6H-SiC sample at 3.5 K, measured using an 892.7 nm laser for excitation. The ZPL transition of the Mo defect visible in this spectrum will be studied in detail throughout this work. The shaded region indicates the emission of phonon replicas related to this ZPL. While we could not perform a detailed analysis, the peak area of the ZPL in comparison with that of the phonon replicas indicates that the ZPL carries clearly more than a few percent of the full PL emission. Similar PL data from Mo in the 4H-SiC sample, together with a study of the temperature dependence of the PL, can be found in Supplementary Information (Fig. S1).

For a more detailed study of the ZPL of the Mo defects, PLE was used. In PLE measurements, the photon energy of a narrowwidth excitation laser is scanned across the ZPL part of the spectrum, while resulting PL of phonon-sideband (phonon-replica) emission is detected (Fig. 1b, we used filters to keep light from the excitation laser from reaching the detector, Methods). The inset of Fig. 1c shows the resulting ZPL for Mo in 6H-SiC at 1.1057 eV (1121.3 nm). For 4H-SiC we measured the ZPL at 1.1521 eV (1076.2 nm, Supplementary Information). Both are in close agreement with literature. Temperature dependence of the PLE from the Mo defects in both 4H-SiC and 6H-SiC can be found in Supplementary Information (Fig. S2).

The width of the ZPL is governed by the inhomogeneous broadening of the electronic transition throughout the ensemble of Mo impurities, which is typically caused by non-uniform strain in the crystal. For Mo in 6H-SiC we observe a broadening of $24 \pm 1$ GHz FWHM, and $23 \pm 1$ GHz for 4H-SiC. This inhomogeneous broadening is larger than the anticipated electronic spin splittings, and it thus masks signatures of spin levels in optical transitions between the ground and excited state.
Fig. 2  Two-laser spectroscopy results for Mo in 6H-SiC. a Working principle of two-laser spectroscopy: one laser at frequency $f_0$ is resonant with the $|g_2\rangle - |e_2\rangle$ transition, the second laser is detuned from the first laser by $\delta$. If $\delta$ is such that the second laser becomes resonant with another transition (here sketched for $|g_1\rangle - |e_1\rangle$) the photoluminescence will increase since optical spin-pumping by the first laser is counteracted by the second and vice versa. b-d Photoluminescence excitation (PLE) signals as a function of two-laser detuning at 4 K. b Magnetic field dependence with field parallel to the c-axis ($\phi = \pi$). For clarity, data in the plot have been magnified by a factor 10 right from the dashed line. Two peaks are visible, labeled $L_1$ and $L_2$ (the small peak at 3300 MHz is an artefact from the Fabry-Pérot interferometer in the setup). c Magnetic field dependence with the field nearly perpendicular to the c-axis ($\phi = 87^\circ$). Three peaks and a dip (enlarged in the inset) are visible. These four features are labeled $L_1$ through $L_4$. The peak positions as a function of field in b, c coincide with straight lines through the origin (within 0.2% error). d Angle dependence of the PLE signal at 300 mT (angles accurate within 2°). Peaks $L_1$ and $L_2$ move to the left with increasing angle, whereas $L_2$ moves to the right. The data in b-d are offset vertically for clarity.

In order to characterize the spin-related fine structure of the Mo defects, a two-laser spectroscopy technique was employed.\textsuperscript{28,41,42} We introduce this for the four-level system sketched in Fig. 2a. A laser fixed at frequency $f_0$ is resonant with one possible transition from ground to excited state (for the example in Fig. 2a $|g_2\rangle$ to $|e_2\rangle$), and causes PL from a sequence of excitation and emission events. However, if the system decays from the state $|e_2\rangle$ to $|g_1\rangle$, the laser field at frequency $f_0$ is no longer resonantly driving optical excitations (the system goes dark due to optical pumping). In this situation, the PL is limited by the (typically long) lifetime of the $|g_1\rangle$ state. Addressing the system with a second laser field, in frequency detuned from the first by an amount $\delta$, counteracts optical pumping into off-resonant energy levels if the detuning $\delta$ equals the splitting $\Delta_0$ between the ground-state sublevels. Thus, for specific two-laser detuning values corresponding to the energy spacings between ground-state and excited-state sublevels the PL response of the ensemble is greatly increased. Notably, this technique gives a clear signal for sublevel splittings that are smaller than the inhomogeneous broadening of the optical transition, and the spectral features now reflect the homogeneous linewidth of optical transitions.\textsuperscript{28,47}

In our measurements a 200 μW continuous-wave control and probe laser were made to overlap in the sample. For investigating Mo in 6H-SiC the control beam was tuned to the ZPL at 1121.32 nm ($f_{\text{control}} = f_0 = 267.3567$ THz), the probe beam was detuned from $f_0$ by a variable detuning $\delta$ (i.e., $f_{\text{probe}} = f_0 + \delta$). In addition, a 100 μW pulsed 770 nm re-pump laser was focused onto the defects to counteract bleaching of the Mo impurities due to charge-state switching\textsuperscript{28,48,49} (which we observed to only occur partially without re-pump laser). All three lasers were parallel to within 3° inside the sample. A magnetic field was applied to ensure that the spin sublevels were at non-degenerate energies. Finally, we observed that the spectral signatures due to spin disappear in a broad background signal above a temperature of ~10 K (Fig. S4), and we thus performed measurements at 4 K (unless stated otherwise).

Figure 2b shows the dependence of the PLE on the two-laser detuning for the 6H-SiC sample (4H-SiC data in Supplementary Information Fig. S6), for a range of magnitudes of the magnetic field (here aligned close to parallel with the c-axis, $\phi = \pi$). Two emission peaks can be distinguished, labeled line $L_1$ and $L_2$. The emission (peak height) of $L_2$ is much stronger than that of $L_1$. Figure 2c shows the results of a similar measurement with the magnetic field nearly orthogonal to the crystal c-axis ($\phi = 87^\circ$), where four spin-related emission signatures are visible, labeled as lines $L_1$, $L_2$, $L_3$, and $L_4$ (a very small peak feature left from $L_1$, at half its detuning, is an artifact that occurs due to a leakage effect in the spectral filtering that is used for beam preparation, see Methods). The two-laser detuning frequencies corresponding to all four lines emerge from the origin ($B = 0$, $\delta = 0$) and evolve linearly with magnetic field (we checked this up to 1.2 T). The slopes of all four lines (in Hertz per Tesla) are smaller in Fig. 2c than in Fig. 2b. In contrast to lines $L_1$, $L_2$, and $L_4$, which are peaks in the PLE spectrum, $L_3$ shows a dip.

In order to identify the lines at various angles $\phi$ between the magnetic field and the c-axis, we follow how each line evolves with increasing angle. Figure 2d shows that as $\phi$ increases, $L_1$, $L_3$, and $L_4$ move to the left, whereas $L_2$ moves to the right. Near 86°, $L_2$ and $L_1$ cross. At this angle, the left-to-right order of the emission lines is swapped, justifying the assignment of $L_1$, $L_2$, $L_3$, and $L_4$ as in Fig. 2b. c Supplementary Information presents further results from two-laser magneto-spectroscopy at intermediate angles $\phi$ (section 2a).

We show below that the results in Fig. 2 indicate that the Mo impurities have electronic spin $S = 1/2$ for the ground and excited state. This contradicts predictions and interpretations of initial results.\textsuperscript{33,38,41,42} Theoretically, it was predicted that the defect associated with the ZPL under study here is a Mo impurity in the asymmetric split-vacancy configuration (Mo impurity asymmetrically located inside a Si–C divacancy), where it would have a spin $S = 1$ ground state with zero-field splittings of about 3–6 GHz.\textsuperscript{33,38,41,42} However, this would lead to the observation of additional emission lines in our measurements. Particularly, in the presence of a zero-field splitting, we would expect to observe two-laser spectroscopy lines emerging from a non-zero detuning.\textsuperscript{28} We have measured near zero fields and up to 1.2 T, as well as from 100 MHz to 21 GHz detuning (Supplementary Information section 2c), but found no more peaks than the four present in Fig. 2c. A larger splitting would have been visible as a splitting of the ZPL in measurements as presented in the inset of Fig. 1c, which was not observed in scans up to 1000 GHz. Additionally, a zero-field splitting and corresponding avoided crossings at certain magnetic fields would result in curved behavior for the positions of lines in magneto-spectroscopy. Thus, our observations rule out that there...
is a zero-field splitting for the ground-state and excited-state spin sublevels. In this case the effective spin-Hamiltonian\textsuperscript{50} can only take the form of a Zeeman term

$$H_{\text{eff}} = \mu_B g_{\parallel} B \cdot \mathbf{S},$$

where $g_{\parallel}$ is the g-factor for the electronic ground (excited) state (both assumed positive), $\mu_B$ the Bohr magneton, $B$ the magnetic field vector of an externally applied field, and $S$ the effective spin vector. The observation of four emission lines can be explained, in the simplest manner, by a system with spin $S = 1/2$ (doublet) in both the ground and excited state.

For such a system, Fig. 3 presents the two-laser optical pumping schemes that correspond to the observed emission lines $L_i$ through $L_4$. Addressing the system with the V-scheme excitation pathways from Fig. 3c leads to increased pumping into a dark ground-state sublevel, since two excited states contribute to decay into the off-resonant ground-state energy level while optical excitation out of the other ground-state level is enhanced. This results in reduced emission observed as the PLE dip feature of $L_3$ in Fig. 2c (for details see Supplementary Information section 5).

We find that for data as in Fig. 2c the slopes of the emission lines are correlated by a set of sum rules

$$\Theta_{13} = \Theta_{11} + \Theta_{12},$$

$$\Theta_{14} = 2\Theta_{11} + \Theta_{12}.$$ 

Here $\Theta_{\parallel}$ denotes the slope of emission line $L_i$ in Hertz per Tesla. The two-laser detuning frequencies for the pumping schemes in Fig. 3a-d are related in the same way, which justifies the assignment of these four schemes to the emission lines $L_i$ through $L_4$, respectively. These schemes and equations directly yield the g-factor values $g_\parallel$ and $g_\perp$ for the ground and excited state (Supplementary Information section 2).

We find that the g-factor values $g_\parallel$ and $g_\perp$ strongly depend on $\phi$, that is, they are highly anisotropic. While this is in accordance with earlier observations for transition metal defects in SiC,\textsuperscript{33} we did not find a comprehensive report on the underlying physical picture. In Supplementary Information section 7, we present a group-theoretical analysis that explains the anisotropy $g_\| = 1.7$ for

$$g_\perp \approx \begin{cases} 0.5 & \text{for } \phi = 0^\circ \text{ and } g_\perp = 0 \text{ for } \phi = 90^\circ, \text{ and similar behavior for } g_e \text{ (which we also use to identify the orbital character of the ground and excited state). In this scenario the effective Landé g-factor\textsuperscript{50} is given by} 
$$

$$g'(\phi) = g_\parallel \cos^2 \phi + g_\perp \sin^2 \phi,$$

where $g_\parallel$ represents the component of $g$ along the $c$-axis of the silicon carbide structure and $g_\perp$ the component in the basal plane. Figure 4 shows the ground and excited state effective g-factors extracted from our two-laser magneto-spectroscopy experiments for 6H-SiC and 4H-SiC (additional experimental data can be found in Supplementary Information). The solid lines represent fits to the Eq. (4) for the effective g-factor. The resulting $g_\parallel$ and $g_\perp$ parameters are given in Table 1.

The reason why diagonal transitions (in Fig. 3a, c), and thus the $\Lambda$ and $V$ scheme are allowed, lies in the different behavior of $g_\parallel$ and $g_\perp$. When the magnetic field direction coincides with the internal quantization axis of the defect, the spin states in both the ground and excited state are given by the basis of the $S_i$ operator,
where the z-axis is defined along the c-axis. This means that the spin-state overlap for vertical transitions, e.g., from |g⟩ to |e⟩, is unity. In such cases, diagonal transitions are forbidden as the overlap between e.g., |g⟩ and |e⟩ is zero. Tilting the magnetic field away from the internal quantization axis introduces mixing of the spin states. The amount of mixing depends on the g-factor, such that it differs for the ground and excited state. This results in a tunable non-zero overlap for all transitions, allowing all four schemes to be observed (as in Fig. 2b where $\phi = 87^\circ$). This reasoning also explains the suppression of all emission lines except $L_2$ in Fig. 2b, where the magnetic field is nearly along the c-axis. A detailed analysis of the relative peak heights in Fig. 2b, c compared to wave function overlap can be found in Supplementary Information (section 4).

The A driving scheme depicted in Fig. 3a, where both ground states are coupled to a common excited state, is of particular interest. In such cases it is possible to achieve all-optical coherent population trapping (CPT), which is of great significance in quantum-optical operations that use ground-state spin coherence. This phenomenon occurs when two lasers address a Λ system at exact two-photon resonance, i.e., when the two-laser detuning matches the ground-state splitting. The ground-state spin system is then driven toward a superposition state that approaches $|\psi_{\text{CPT}}\rangle \approx |g\rangle - |e\rangle$ for ideal spin coherence. Here $|\Omega_n\rangle$ is the normal CPT feature depths

\[
g \quad \text{component of the g-factor for the spin of Mo impurities in SiC.}
\]

<table>
<thead>
<tr>
<th></th>
<th>$g_1$</th>
<th>$g_2$</th>
</tr>
</thead>
<tbody>
<tr>
<td>4H-SiC Ground</td>
<td>1.67 ± 0.2</td>
<td>0.04 ± 0.04</td>
</tr>
<tr>
<td>Excited state</td>
<td>1.39 ± 0.2</td>
<td>0.10 ± 0.02</td>
</tr>
<tr>
<td>6H-SiC Ground</td>
<td>1.61 ± 0.02</td>
<td>0.000 ± 0.004</td>
</tr>
<tr>
<td>Excited state</td>
<td>1.20 ± 0.02</td>
<td>0.11 ± 0.02</td>
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In order to study the occurrence of CPT, we focus on the three transitions for which the line is scanned across the line in frequency steps of $50 \text{ kHz}$, at $200 \mu\text{W}$. The control laser power was varied between $200 \mu\text{W}$ and $5 \text{ mW}$. This indeed yields signatures of CPT, as presented in Fig. 5. A clear power dependence is visible: when the control beam power is increased, the depth of the CPT dip increases (and can fully develop at higher laser powers or by concentrating laser power dependence is visible: when the control beam power is). This observation of CPT can be traced back to a combination of a crystal field with $C_{6v}$ symmetry and spin-orbit coupling for the specific case of an ion with one electron in its d-orbital.

**DISCUSSION**

The anisotropic behavior of the g-factor that we observed for Mo was also observed for vanadium and titanium in the EPR studies by Baur et al. (they observed $g_2 \approx 1.7$ and $g_1 = 0$ for the ground state). In these cases the metal has a single electron in its 3d orbital and occupies the hexagonal (h) Si substitutional site. We show in Supplementary Information section 7 that the origin of this behavior can be traced back to a combination of a crystal field with $C_{6v}$ symmetry and spin-orbit coupling for the specific case of an ion with one electron in its d-orbital.

The correspondence of this behavior with what we observe for the Mo impurity identifies that our materials have Mo impurities present as Mo$^{5+}$ (4d$^2$) systems residing on a hexagonal h silicon substitutional site. In this case of a hexagonal (h) substitutional site, the molybdenum is bonded in a tetrahedral geometry, sharing four electrons with its nearest neighbors. For Mo$^{5+}$ (4d$^2$) the defect is then in a singly ionized +1 charge state (e denotes the electronic charge), due to the transfer of one electron to the p-type SiC host material.

An alternative scenario for our type of Mo impurities was recently proposed by Ivády et al. They proposed, based on theoretical work, the existence of the asymmetric split-vacancy (ASV) defect in SiC. An ASV defect in SiC occurs when an impurity occupies the interstitial site formed by adjacent silicon and carbon vacancies. The local symmetry of this defect is a distorted octahedron with a threefold symmetry axis in which the strong g-factor anisotropy ($g_1 = 0$) may also be present for the $S = 1/2$ state. Considering six shared electrons for this divacancy...
environment, the Mo\(^{5+}\) (4d\(^1\)) Mo configuration occurs for the singly charged \(-|e|\) state. For this configuration, the Zeeman effect is negligible. However, the probability of finding the Mo defect at a silicon substitutional site, thus yielding a 3d\(^2\) configuration, is low. This is because Mo in SiC, the Cr defect is located at a silicon substitutional site, yielding a 3d\(^2\) configuration, while the Cr defect is located at a silicon substitutional site, yielding a 3d\(^2\) configuration.

Another defect worth comparing to is the aforementioned chromium defect, studied by Koehl et al.\(^{37}\). Like Mo in SiC, the Cr defect is located at a silicon substitutional site, yielding a 3d\(^2\) configuration. This defect is allowed in hexagonal symmetry, but forbidden in cubic, we found that the Mo defect we studied, hampering its application as a bright emitter. It is clear that there is a wide variety in optical and spin properties throughout transition-metal impurities in SiC, spin properties throughout transition-metal impurities in SiC. This defect displays a wide variety in optical and spin properties throughout transition-metal impurities in SiC.

We have studied ensembles of molybdenum defect centers in 6H and 4H silicon carbide with 1.5252 eV and 1.057 eV transition energies, respectively. The ground-state and excited-state spin of both defects was determined to be \(S = 1/2\) with large g-factor anisotropy. Since this is allowed in hexagonal symmetry, but forbidden in cubic, we found that the Mo defect we studied, hampering its application as a bright emitter. It is clear that there is a wide variety in optical and spin properties throughout transition-metal impurities in SiC, which makes up a useful library for engineering quantum technologies with spin-active color centers.

The PLE setup described above was modified by focusing a detuned laser beam to the sample, in addition to the present beams. The detuned laser field was generated by splitting off part of the stabilized diode laser beam. This secondary beam was coupled into a single-mode fiber and passed through an electro-optic phase modulator in which an RF signal (up to ~5 GHz) modulated the phase. Several sidebands were created next to the fundamental laser frequency, the spacing of these sidebands was determined by the RF frequency. Next, a Fabry–Pérot interferometer was used to select one of the first-order sidebands (and it was locked to the selected mode). The resulting beam was focused on the same region in the sample as the original PLE beams (diode laser and re-pump) with similar spot size and polarization along the sample c-axis. Laser powers were as mentioned in the main text. Small rotations of the c-axis with respect to the magnetic field were performed using a piezo-actuated goniometer with 7.2 degrees travel.

Data processing
For all graphs with PLE data a background count rate is subtracted from each line, determined by the minimum value of the PLE in that line (far away from resonance features). After this a fixed vertical offset is added for clarity. For each graph, the scaling is identical for all lines within that graph.

DATA AVAILABILITY
The data sets generated and analyzed during the current study are available from the corresponding author upon reasonable request.

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AUTHOR CONTRIBUTIONS
The project was initiated by C.H.v.d.W., O.V.Z., I.G.I., and N.T.S. SiC materials were grown and prepared by A.E. and B.M. Experiments were performed by T.B., G.J.J.L., and O.V.Z., except for the PL measurements which were done by A.G. and I.G.I. Data analysis was performed by T.B., G.J.J.L., C.G., O.V.Z., F.H., R.W.A.H., and C.H.W. L. and B.M. had the lead on writing the paper, and T.B. and G.J.J.L. are co-first authors. All authors read and commented on the manuscript.

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